Search	Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/784,268	USUI, RYOSUKE	
Examiner	Art Unit	
Hoai v. Pham	2814	

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	659	6/21/2005	НР
257	660	6/21/2005	HP
257	678	6/21/2005	НР

INT	INTERFERENCE SEARCHED		
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